

<b>Notice of References Cited</b>	Application/Control No. 09/750,986	Applicant(s)/Patent Under Reexamination STEINBUCHER ET AL.	
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	U	Witkowski et al. , Biochemistry 38:11643-11650, 1999
	V	Broun et al. , Science 282:1315-1317, 1998
	W	Seffernick et al. , J. Bacteriol. 183(8):2405-2410, 2001
	X	Priefert et al. , J. Bacteriol 179(8):2595-2607, April 1997

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